

**Search Notes****Application/Control No.**

10/808,474

**Examiner**

Charles Chow

**Applicant(s)/Patent under Reexamination**

NAKAO ET AL.

**Art Unit**

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	<u>138</u> ,	7/21/2006	C.C.
	<u>424, 425</u> ,	<u>456, 5, 456, 6</u> ,	<u>550, 1, 575, 1</u> ,
	<u>561, 13.3</u> ,	<u>101*</u> , <u>13.4</u> ,	<u>115.3</u> ,
	→ <u>522*</u> ,	<u>525</u> , <u>67.11</u> ,	<u>69, 562, 1</u> ,
	<u>132, 135</u> ,	<u>161, 3, 276, 1</u> ,	<u>277, 1</u> ,
	<u>63.4, 504</u> ,	<u>103, 276, 1</u> ,	<u>277, 2</u> ,
	<u>272, 88</u> ,	<u>24, 25, 65</u> ,	<u>67.1, 136</u> ,
375	<u>347, 349</u> ,	<u>220, 219</u> ,	<u>221</u>
	<u>264, 261</u> ,	<u>285</u> ,	
370	<u>334, 342</u> ,	<u>335, 339</u> ,	
342	<u>378, 828</u> ,	<u>850, 853</u> ,	<u>380</u> ,
	<u>383, 382</u> ,	<u>372, 368</u> ,	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See East search in eDAN.	7/21/2006	C.C.